

Features

- High Gain: 24 dB @ 30 GHz
- P1dB: 34.5 dBm
- P_{SAT}: 36.5 dBm
- IM3 Level: -27 dBc @ P_{OUT} = 29 dBm/tone
- Power Added Efficiency: 23% @ P_{SAT}
- Return Loss: 10 dB
- Bare Die Dimensions: 3.1 x 2.8 x 0.05 mm
- RoHS* Compliant

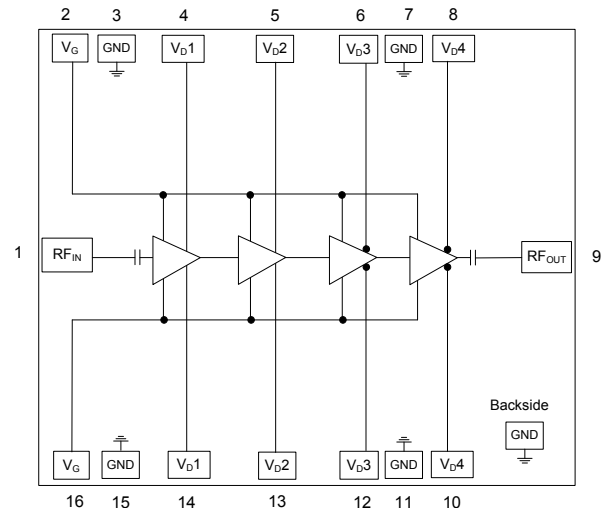
Description

The MAAP-011139-DIE is a 4-stage, 4 W power amplifier in bare die form. This power amplifier operates from 29 to 31 GHz and provides 24 dB of linear gain, 4 W saturated output power, and 23% efficiency while biased at 6 V.

The MAAP-011139-DIE is a power amplifier ideally suited for VSAT communications.

This product is fabricated using a GaAs pHEMT device process which features full passivation for enhanced reliability.

Functional Diagram



Pin Configuration²

Pad	Function	Description
1	RF _{IN}	RF Input
2, 16	V _G	Gate Voltage
3, 7, 11, 15 & backside	GND	Ground
4, 14	V _{D1}	Drain Voltage 1
5, 13	V _{D2}	Drain Voltage 2
6, 12	V _{D3}	Drain Voltage 3
8, 10	V _{D4}	Drain Voltage 4
9	RF _{OUT}	RF Output

2. Backside metal is RF, DC and thermal ground.

Ordering Information

Part Number	Package
MAAP-011139-DIE	Die in Gel Pack ¹

1. Die quantity varies

* Restrictions on Hazardous Substances, European Union Directive 2011/65/EU.

Power Amplifier, 4 W 29 - 31 GHz

Rev. V1

Electrical Specifications³: Freq. = 30 GHz, $T_C = +25^\circ\text{C}$, $V_D = +6\text{ V}$, $Z_0 = 50\ \Omega$

Parameter	Test Conditions	Units	Min.	Typ.	Max.
Gain	$P_{IN} = 0\text{ dBm}$	dB	22	24	—
P_{OUT}	$P_{IN} = 17\text{ dBm}$	dBm	35.0	36.5	—
IM3 Level	$P_{OUT} = 29\text{ dBm / tone}$	dBc	—	-27	—
Power Added Efficiency	$P_{SAT} (P_{IN} = 17\text{ dBm})$	%	—	23	—
Input Return Loss	$P_{IN} = -20\text{ dBm}$	dB	—	10	—
Output Return Loss	$P_{IN} = -20\text{ dBm}$	dB	—	10	—
Quiescent Current	I_{DQ} (see bias conditions, page 5)	mA	—	2000	—
Current	$P_{SAT} (P_{IN} = +17\text{ dBm})$	mA	—	3200	—

3. Specifications apply to MMIC die with two RF input and two RF output bond wires.

Maximum Operating Ratings

Parameter	Rating
Input Power	+17 dBm
Junction Temperature ^{4,5}	+160°C
Operating Temperature	-40°C to +85°C

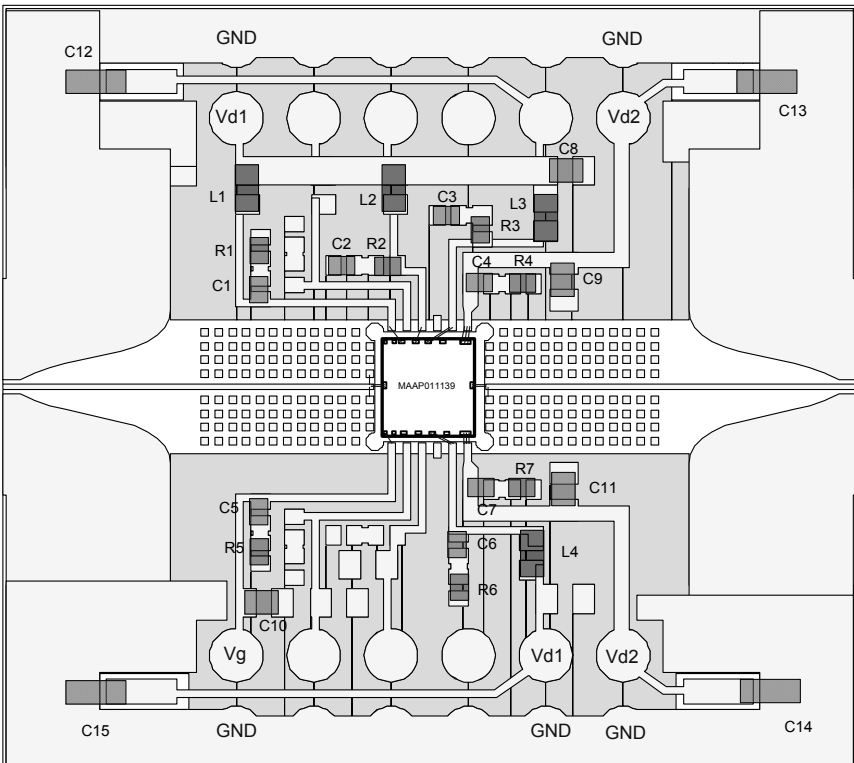
4. Operating at nominal conditions with junction temperature $\leq +160^\circ\text{C}$ will ensure MTTF $> 1 \times 10^6$ hours.
5. Junction Temperature (T_J) = $T_C + \Theta_{JC} * ((V * I) - (P_{out} - P_{IN}))$
Typical thermal resistance (Θ_{JC}) = 3.4°C/W.
- a) For $T_C = +25^\circ\text{C}$,
 $T_J = +75^\circ\text{C}$ @ 6 V, 3.2 A, $P_{OUT} = 36.5\text{ dBm}$, $P_{IN} = 17\text{ dBm}$
- b) For $T_C = +85^\circ\text{C}$,
 $T_J = +133^\circ\text{C}$ @ 6 V, 3.0 A, $P_{OUT} = 36.0\text{ dBm}$, $P_{IN} = 17\text{ dBm}$

Absolute Maximum Ratings^{6,7}

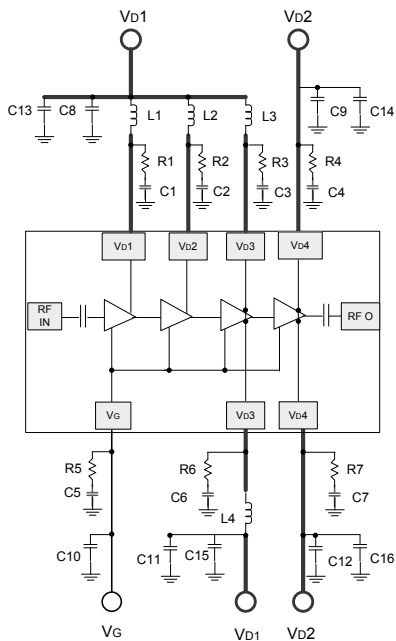
Parameter	Absolute Maximum
Input Power	+23 dBm
Drain Voltage	+6.5 V
Gate Voltage	-3 to 0 V
Junction Temperature ⁸	+175°C
Storage Temperature	-65°C to +150°C

6. Exceeding any one or combination of these limits may cause permanent damage to this device.
7. MACOM does not recommend sustained operation near these survivability limits.
8. Junction temperature directly effects device MTTF. Junction temperature should be kept as low as possible to maximize lifetime.

Application PCB Layout



Application Diagram



Application Parts List

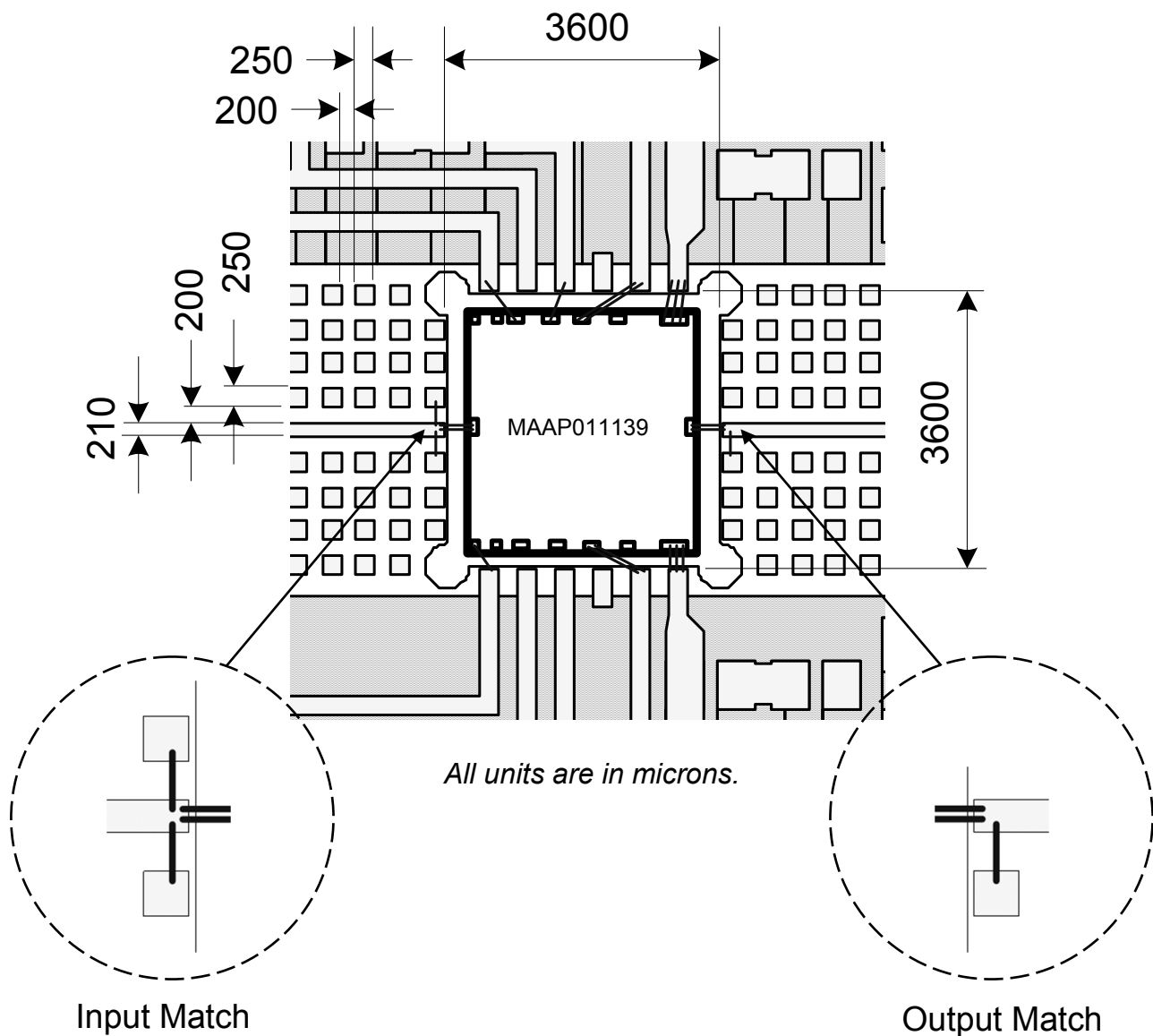
Part	Value	Case Style
C1 - C7	0.01 μ F	0402
C8 - C12	1 μ F	0603
C13 - C16	10 μ F	0805
R1 - R7	10 Ω	0402
L1 - L4 (Chip Ferrite Bead)	BLM18HE601SN1D	0603

PCB Material Specifications

Top Layer: 1/2 oz Copper Cladding, 0.017 mm thickness
Dielectric Layer: Rogers RO4350B, 0.101 mm thickness
Bottom Layer: 1/2 oz Copper Cladding, 0.017 mm thickness
Finished overall thickness: 0.135 mm

Recommended Bonding Diagram and PCB Layout Detail:

For optimum power match, RF input and output microstrip lines require open stubs on the application board for bonding wire inductance compensation. Optimum bonding wire inductance for the RF I/O connection is 0.2 nH, and physical length for the gold bond wire (.001" dia.) is approximately 350 μm each for the two wire connection.



Application Information

The MAAP-011139 is designed to be easy to use yet high performance. The ultra small size and simple bias allow easy placement on system board. RF input and output ports are DC de-coupled internally.

Biasing conditions

Recommended biasing conditions are $V_D = 6$ V, $I_{DQ} = 2000$ mA (controlled with V_G). The drain bias voltage range is 3 to 6 V, and the quiescent drain current biasing range is 1500 to 2500 mA.

V_G pads 2 and 16 are connected internally; choose either pad for layout convenience. Muting can be accomplished by setting the V_G to the pinched off voltage ($V_G = -2$ V).

V_D bias must be applied to V_{D1} , V_{D2} , V_{D3} , and V_{D4} pads.

V_{D1} pads 4 and 14 are connected internally, and only one pad is required for biasing. Choose either pad for layout convenience.

V_{D2} pads 5 and 13 are connected internally, and only one pad is required for biasing. Choose either pad for layout convenience.

Both V_{D3} pads (6 and 12) are required for current symmetry.

Both V_{D4} pads (8 and 10) are required for current symmetry.

Die Attachment

This product is manufactured from 0.050 mm (0.002") thick GaAs substrate and has vias through to the backside to enable grounding to the circuit.

Recommended conductive epoxy is Namics Unimec XH9890-6. Epoxy should be applied and cured in accordance with the manufacturer's specifications and should avoid contact with the top of the die.

Operating the MAAP-011139-DIE

Turn-on

1. Apply V_G (-1.5 V).
2. Apply V_D (6.0 V typical).
3. Set I_{DQ} by adjusting V_G more positive (typically $V_G \sim -0.9$ V for $I_{DQ} = 2000$ mA).
4. Apply RF_{IN} signal.

Turn-off

1. Remove RF_{IN} signal.
2. Decrease V_G to -1.5 V.
3. Decrease V_D to 0 V.

Handling Procedures

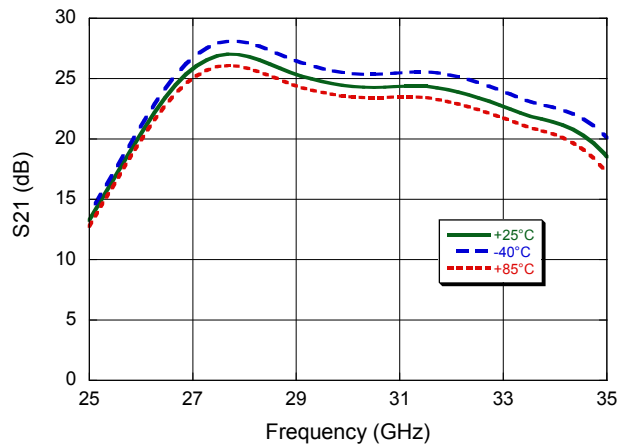
Please observe the following precautions to avoid damage:

Static Sensitivity

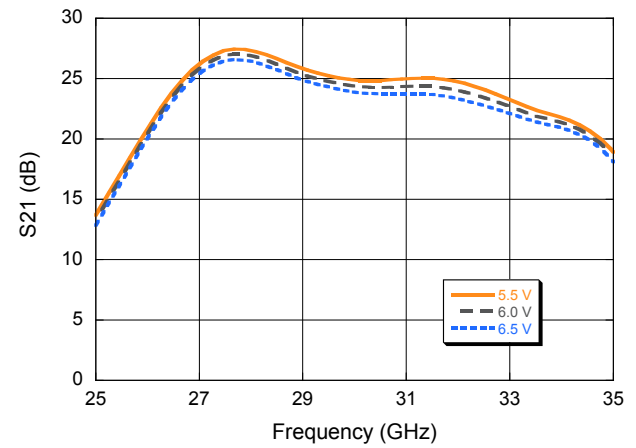
These electronic devices are sensitive to electrostatic discharge (ESD) and can be damaged by static electricity. Proper ESD control techniques should be used when handling these HBM Class 1A devices.

Typical Performance Curves⁹

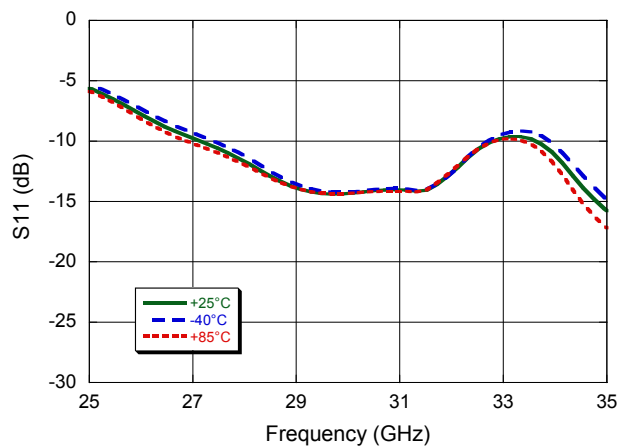
Small Signal Gain vs. Frequency over Temperature



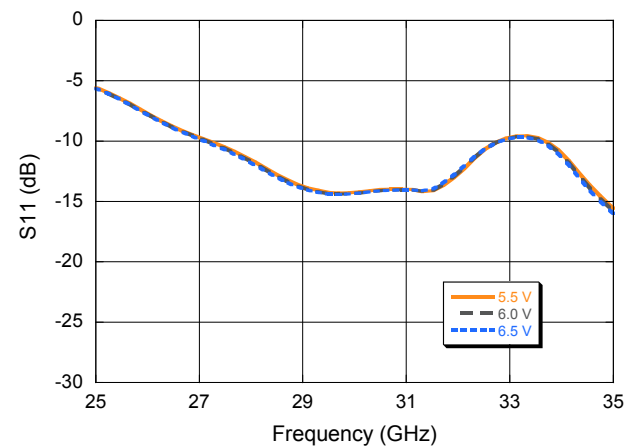
Small Signal Gain vs. Frequency over Bias Voltage



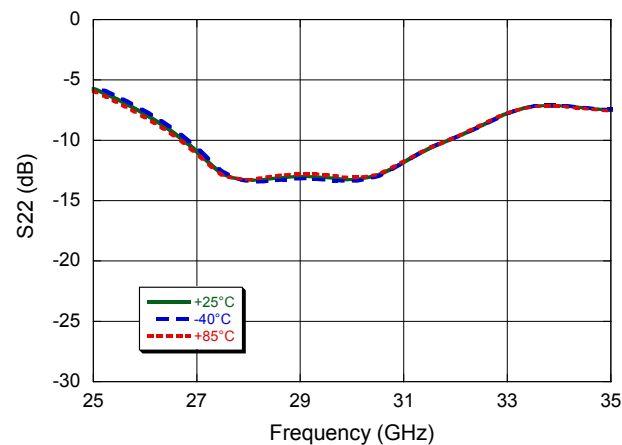
Input Return Loss vs. Frequency over Temperature



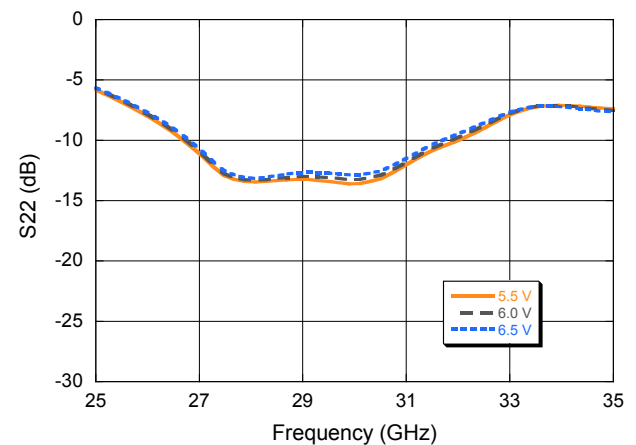
Input Return Loss vs. Frequency over Bias Voltage



Output Return Loss vs. Frequency over Temperature

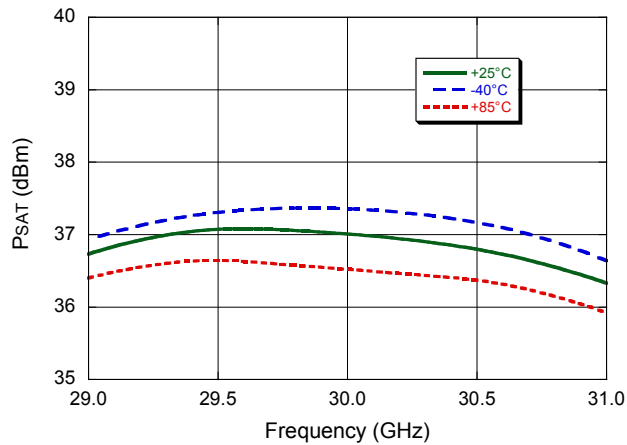


Output Return Loss vs. Frequency over Bias Voltage

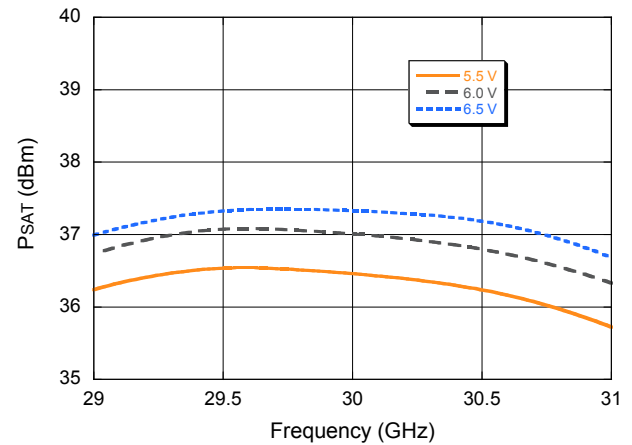


Typical Performance Curves⁹

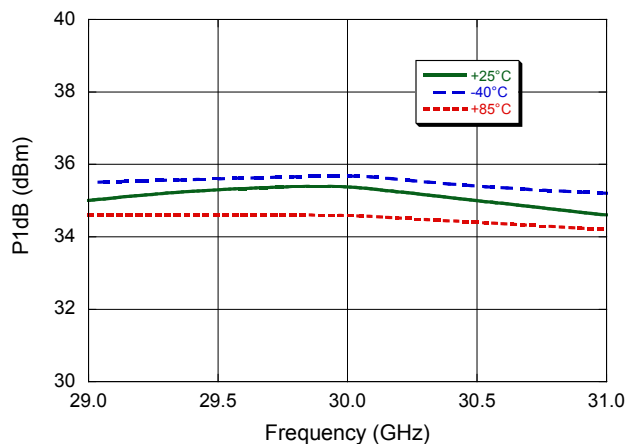
P_{SAT} vs. Frequency over Temperature



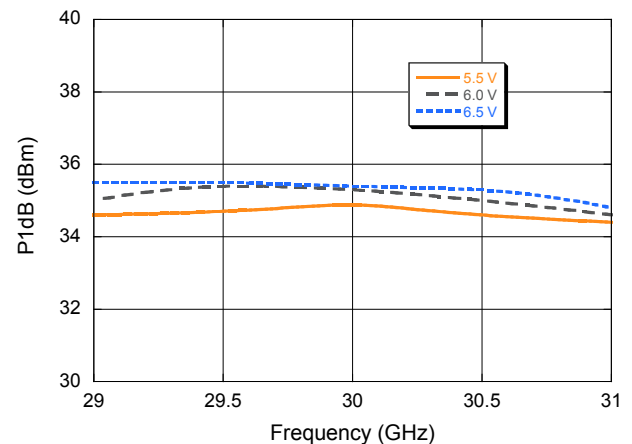
P_{SAT} vs. Frequency over Bias Voltage



$P1dB$ vs. Frequency over Temperature

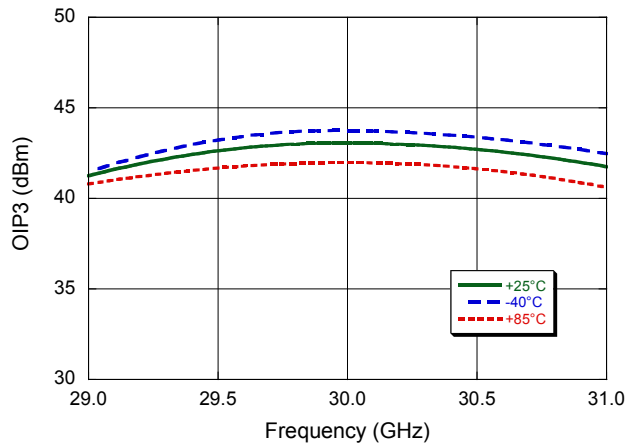


$P1dB$ vs. Frequency over Bias Voltage

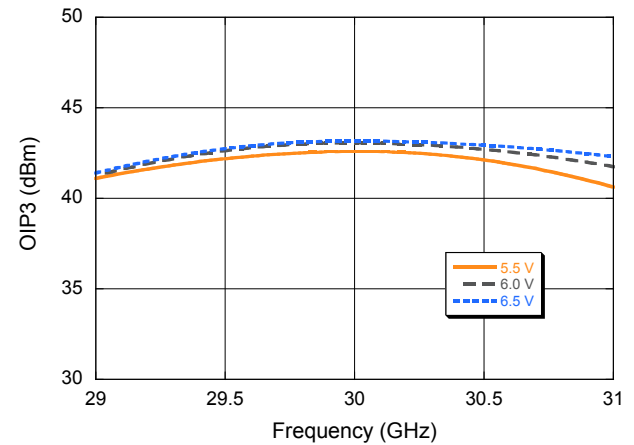


Typical Performance Curves⁹

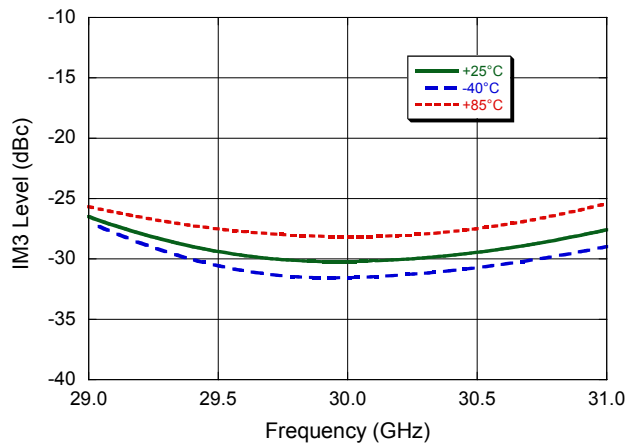
Output IP3 vs. Frequency over Temperature



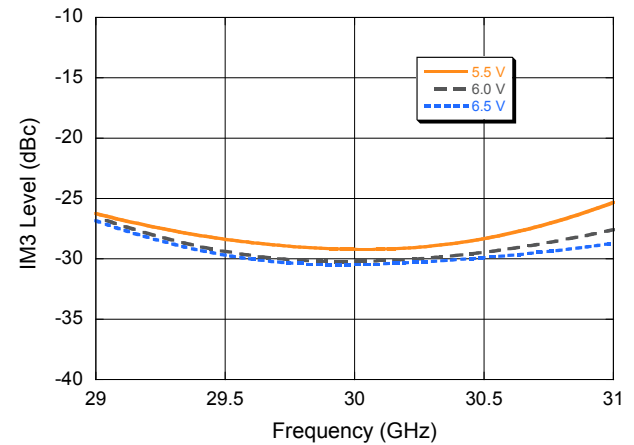
Output IP3 vs. Frequency over Bias Voltage



IM3 vs. Frequency over Temperature
($P_{OUT} = +29$ dBm/Tone)

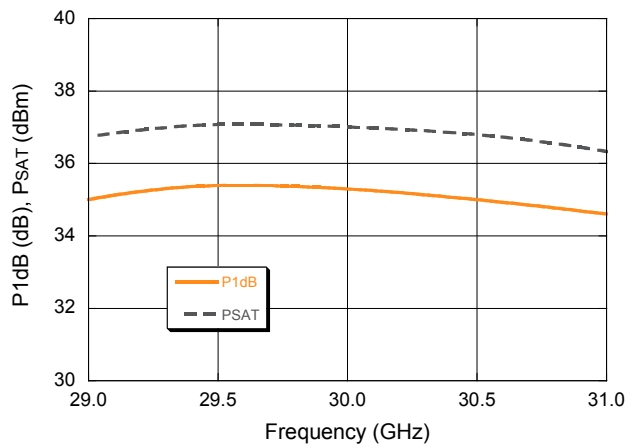


IM3 vs. Frequency over Bias Voltage
($P_{OUT} = +29$ dBm/Tone)

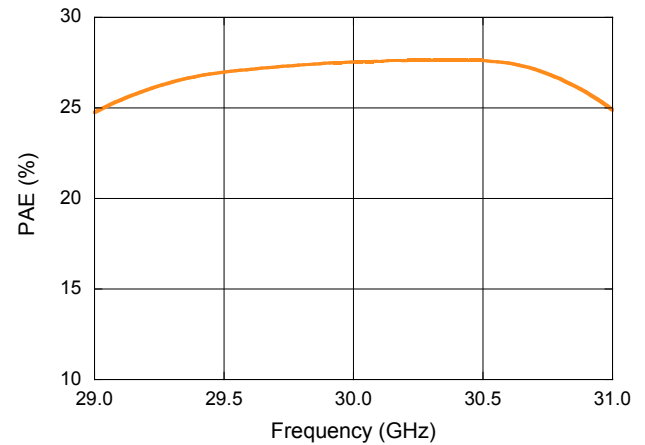


Typical Performance Curves⁹

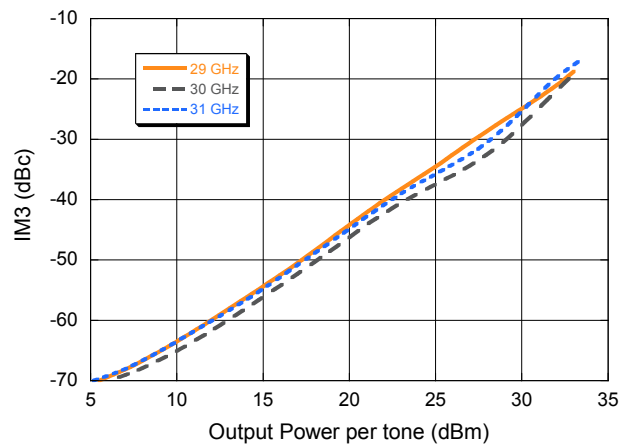
P_{1dB}, P_{SAT} vs. Frequency



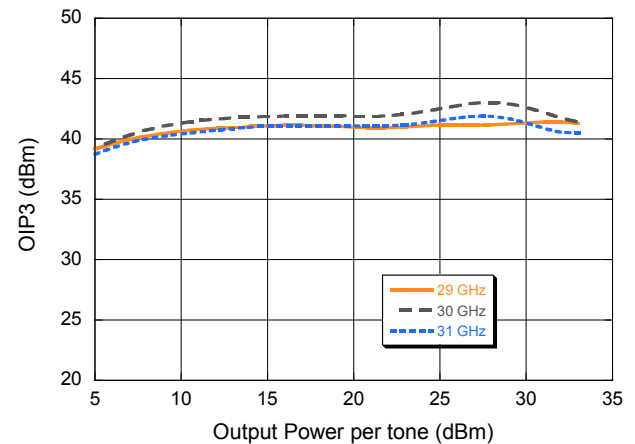
PAE vs. Frequency



IM3 vs. Output Power per Tone

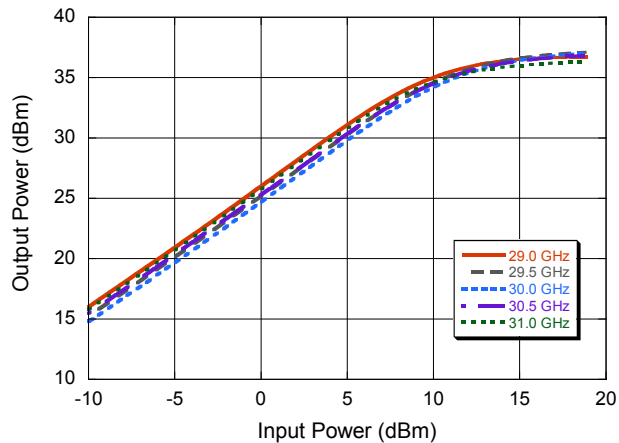


Output IP3 vs. Output Power per Tone

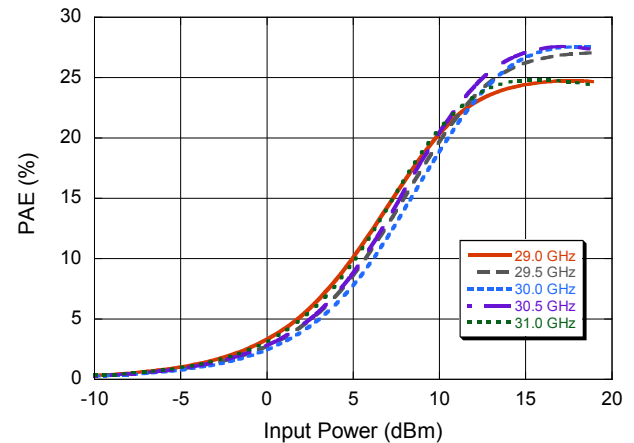


Typical Performance Curves⁹

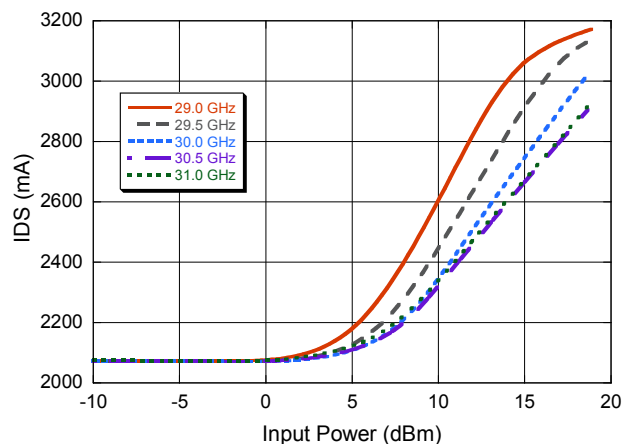
Output Power vs. Input Power



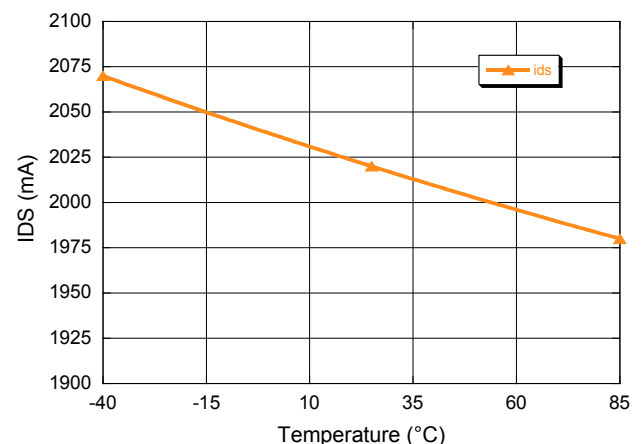
PAE vs. Input Power



Drain Current vs. Input Power

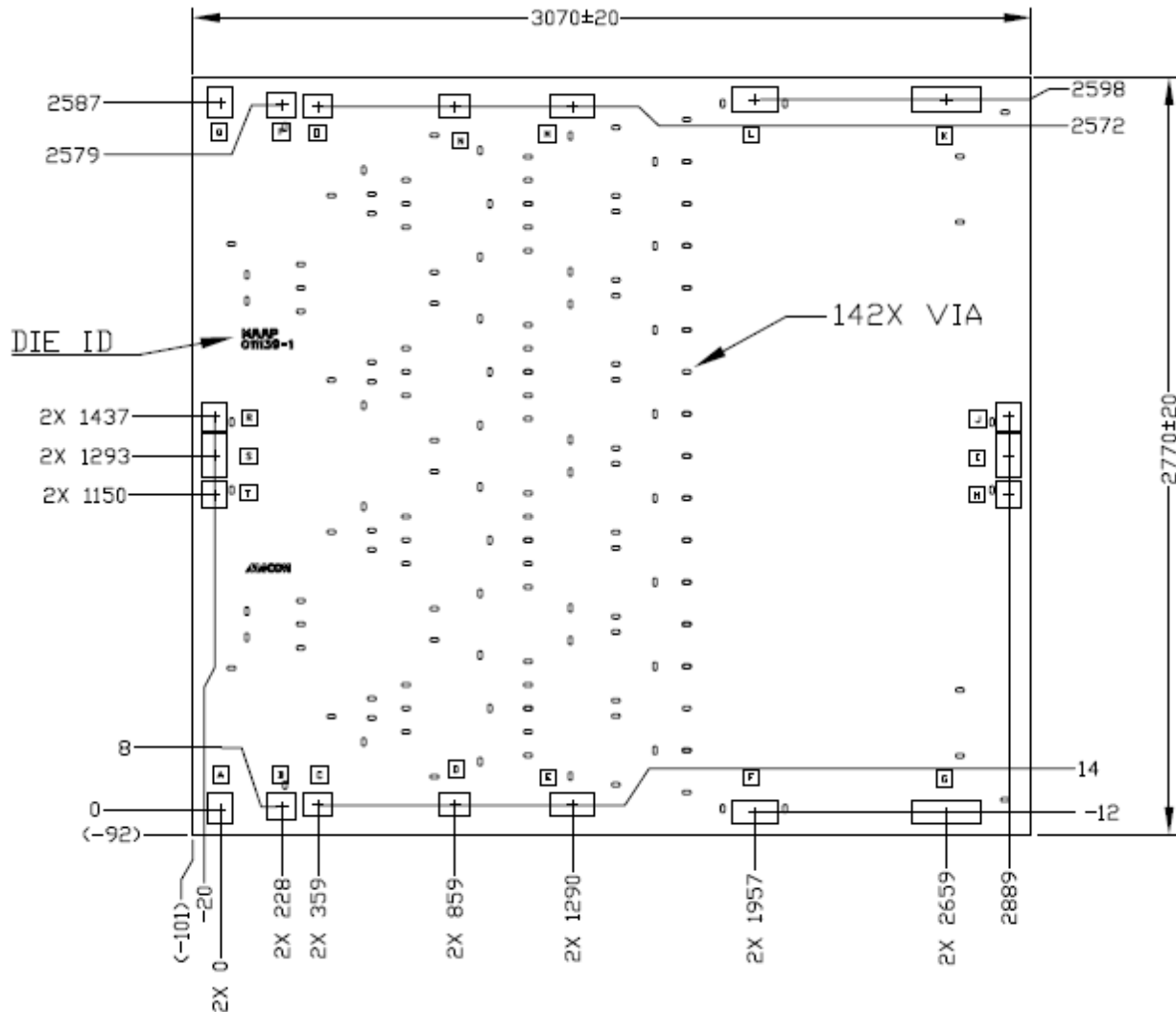


Quiescent Drain Current over Temperature



9. Typical performance curves are achieved by using the recommended bonding diagram and PCB layout detail.

MMIC Die Outline



Bond Pad Detail

Pad	Size (x)	Size (y)
A, Q	88	112
B, P	105	96
C, D, O, N	108	83
E, M	163	83
F, L	169	88
G, K	248	88
H, J, R, T	89	99
I, S	89	159

Notes:

1. All units are in μm , unless otherwise noted, with a tolerance of $\pm 5 \mu\text{m}$.
2. Die thickness is $50 \pm 10 \mu\text{m}$.

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- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
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- Комплексную поставку.
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- Формирование склада под заказчика.
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- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



Тел: +7 (812) 336 43 04 (многоканальный)

Email: org@lifeelectronics.ru

www.lifeelectronics.ru